

<b>Notice of References Cited</b>	Application/Control No. 10/651,055	Applicant(s)/Patent Under Reexamination MITAL ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,974,791	11-1999	Hirota et al.	60/276
	B	US-6,170,259	01-2001	Boegner et al.	60/286
	C	US-5,910,097	06-1999	Boegner et al.	60/278
	D	US-5,085,049	02-1992	Rim et al.	60/274
	E	US-5,406,790	04-1995	Hirota et al.	60/276
	F	US-6,318,073	11-2001	Boegner et al.	60/274
	G	US-5,613,359	03-1997	Zahn et al.	60/274
	H	US-6,293,096	09-2001	Khair et al.	60/286
	I	US-6,233,927	05-2001	Hirota et al.	60/297
	J	US-6,502,391	01-2003	Hirota et al.	60/288
	K	US-6,105,365	08-2000	Deeba et al.	60/274
	L	US-6,023,929	02-2000	Ma, Thomas Tsoi-Hei	60/295
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 60-045711	03-1985	Japan	Kume et al.	
	O	JP 6-33735	02-1994	Japan	Eguchi	
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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